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#### **Features**

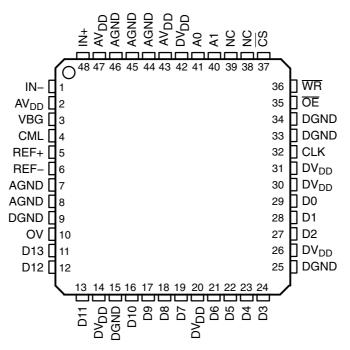
- Controlled Baseline
  - One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance up to -55°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product Change Notification
- Qualification Pedigree<sup>†</sup>
- 14-Bit Resolution
- 3- and 8-MSPS Speed Grade
- Differential Nonlinearity (DNL) ±0.6 LSB Typ
- † Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Integral Nonlinearity (INL) ±1.5 LSB Typ
- Internal Reference
- Differential Inputs
- Programmable Gain Amplifier
- μP-Compatible Parallel Interface
- Timing Compatible With TMS320C6000 DSP
- 3.3-V Single Supply
- Power-Down Mode
- Monolithic CMOS Design

#### **Applications**

- xDSL Front Ends
- Communication
- Industrial Control
- Instrumentation
- Automotive and Selected Military

# PHP PACKAGE (TOP VIEW)



NC - No internal connection



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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#### description

The THS1408 is a 14-bit, 3/8-MSPS single-supply analog-to-digital converter (ADC), with an internal reference, differential inputs, programmable input gain, and an on-chip sample and hold amplifier.

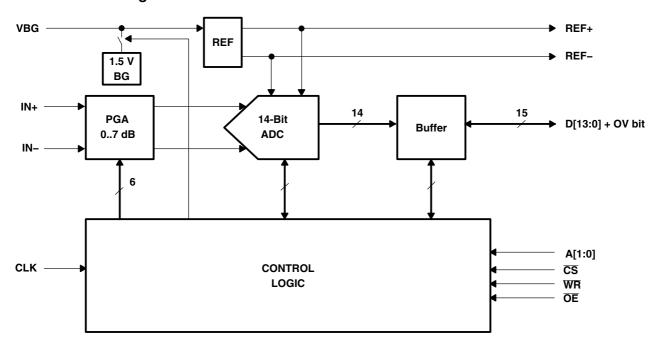
Implemented with a CMOS process, the device has outstanding price/performance and power/speed ratios. The THS1408 is designed for use with 3.3-V systems, and with a high-speed µP-compatible parallel interface, making it the first choice for solutions based on high-performance DSPs like the TI TMS320C6000 series.

#### ORDERING INFORMATION

T <sub>A</sub>	T <sub>A</sub> PACKAGE <sup>†</sup>		TOP-SIDE MARKING		
-55°C to 125°C	PQFP – PHP	THS1408MPHPEP	THS1408ME		

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

#### functional block diagram





# **THS1408-EP** 14-BIT, 3/8 MSPS DSP-COMPATIBLE ANALOG-TO-DIGITAL CONVERTER WITH INTERNAL REFERENCE AND PGA SGLS129B - JULY 2002 - REVISED FEBRUARY 2010

#### **Terminal Functions**

TER	MINAL		
NAME	NO.	I/O	DESCRIPTION
A[1:0]	40, 41	I	Address input
AGND	7,8, 44, 45, 46		Analog ground
$AV_{DD}$	2, 43, 47		Analog power supply
CLK	32	- 1	Clock input
CML	4		Reference midpoint. This pin requires a 0.1-μF capacitor to AGND.
CS	37	I	Chip select input. Active low
DGND	9, 15, 25, 33, 34		Digital ground
DV <sub>DD</sub>	14, 20, 26, 30, 31, 42		Digital power supply
D[13:0]	11, 12, 13, 16, 17, 18, 19, 21, 22, 23, 24, 27, 28, 29	I/O	Data inputs/outputs
NC	38, 39		No connection, do not use. Reserved
IN+	48	I	Positive differential analog input
IN-	1	I	Negative differential analog input
ŌĒ	35	I	Output enable. Active low
OV	10	0	Out of range output
REF+	5	0	Positive reference output. This pin requires a 0.1-μF capacitor to AGND.
REF-	6	0	Negative reference output. This pin requires a 0.1-μF capacitor to AGND.
VBG	3	I	Reference input. This pin requires a 1-μF capacitor to AGND.
WR	36	I	Write signal. Active low

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#### absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, (AV <sub>DD</sub> to AGND)		
Supply voltage, (DV <sub>DD</sub> to DGND)		
Reference input voltage range, VBG		
Analog input voltage range		– 0.3 V to AV <sub>DD</sub> + 0.3 V
Digital input voltage range		– 0.3 V to DV <sub>DD</sub> + 0.3 V
Operating free-air temperature range, T <sub>A</sub> :	Q suffix	–40°C to 125°C
	M suffix	55°C to 125°C
Storage temperature range, T <sub>stq</sub>		
Lead temperature 1.6 mm (1/16 inch) from	case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### THERMAL CHARACTERISTICS

	TYP	UNIT
Thermal resistance, junction-to-ambient, $\Theta_{JA}$	28.8	°C/W
Thermal resistance, junction-to-case, $\Theta_{\mbox{\scriptsize JC}}$	0.79	°C/W

<sup>&</sup>lt;sup>†</sup> Thermal resistance is modeled data, is not production tested, and is given for informational purposes only.

#### recommended operating conditions

			MIN	NOM	MAX	UNIT
Supply voltage, AV <sub>DD</sub> , DV <sub>DD</sub>		3	3.3	3.6	V	
High level digital input, V <sub>IH</sub>						V
Low level digital input, V <sub>IL</sub>			0	0.8	V	
Load capacitance, C <sub>L</sub>			5	15	pF	
Clock frequency, f <sub>CLK</sub>			0.1	8	8	MHz
Clock duty cycle			45%	50%	55%	
<b>.</b>	Q suffix		-40	25	125	°C
Operating free-air temperature	M suffix		-55	25	125	Ŷ.



# **THS1408-EP** 14-BIT, 3/8 MSPS DSP-COMPATIBLE ANALOG-TO-DIGITAL CONVERTER WITH INTERNAL REFERENCE AND PGA SGLS129B - JULY 2002 - REVISED FEBRUARY 2010

# electrical characteristics over recommended operating free-air temperature range, $AV_{DD} = DV_{DD} = 3.3 \text{ V}$ (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT			
Power 9	Supply									
I <sub>DDA</sub>	Analog supply current		AV <sub>DD</sub> = 3.6 V		81	90	mA			
I <sub>DDD</sub>	Digital supply current		DV <sub>DD</sub> = 3.6 V		5	10	mA			
	Power		$AV_{DD} = DV_{DD} = 3.6 \text{ V}$		270	360	mW			
	Power down current				20		μΑ			
DC Cha	racteristics									
	Resolution				14		Bits			
DNL	Differential nonlinearity				±0.6	±1	LSB			
15.11		THS1408 at 3 MSPS	Best fit		±2	±4				
INL	Integral nonlinearity	THS1408 at 8 MSPS	Best fit		±3.5	±10.5	LSB			
	Offset error		IN+ = IN-, PGA = 0 dB			0.3	%FSR			
	Gain error		PGA = 0 dB			1.75	%FSR			
AC Cha	racteristics									
ENOB	Effective number of bits			11.2	11.5		Bits			
			f <sub>i</sub> = 100 kHz		-81					
THD	Total harmonic distortion		f <sub>i</sub> = 1 MHz		-78		dB			
			f <sub>i</sub> = 4 MHz		-77					
			f <sub>i</sub> = 100 kHz		72					
SNR	Signal-to-noise ratio		f <sub>i</sub> = 1 MHz	70	72		dB			
			f <sub>i</sub> = 4 MHz		71					
			f <sub>i</sub> = 100 kHz		70					
SINAD	Signal-to-noise ratio + distortion		f <sub>i</sub> = 1 MHz	69	70		dB			
			f <sub>i</sub> = 4 MHz		70					
			f <sub>i</sub> = 100 kHz		80					
SFDR	Spurious free dynamic range		f <sub>i</sub> = 1 MHz	71	80		dB			
			f <sub>i</sub> = 4 MHz		80					
	Analog input bandwidth				140		MHz			

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# electrical characteristics over recommended operating free-air temperature range, $AV_{DD} = DV_{DD} = 3.3 \text{ V}$ (unless otherwise noted) (continued)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Refere	nce Voltage	·				•
	Bandgap voltage, internal mode		1.425	1.5	1.575	V
VBG	Input impedance			40		kΩ
	Positive reference voltage, REF+			2.5		V
	Negative reference voltage, REF-			0.5		V
	Reference difference, ∆REF, REF+ – REF–			2		V
	Accuracy, internal reference			5%		
	Temperature coefficient			40		ppm/°C
	Voltage coefficient			200		ppm/V
Analog	Inputs		•			•
	Positive analog input, IN+		0		$AV_{DD}$	V
	Negative analog input, IN-		0		$AV_{DD}$	V
	Analog input voltage difference	ΔAin = IN+ – IN-, V <sub>ref</sub> = REF+ – REF-	-V <sub>ref</sub>		V <sub>ref</sub>	V
	Input impedance			25		kΩ
	PGA range		0		7	dB
	PGA step size			1		dB
	PGA gain error				±0.25	dB
Digital	Inputs					
V <sub>IH</sub>	High-level digital input		2			V
$V_{IL}$	Low-level digital input				0.8	V
	Input capacitance			5		pF
	Input current				±1	μΑ
Digital	Outputs					
V <sub>OH</sub>	High-level digital output	I <sub>OH</sub> = 50 μA	2.6			V
V <sub>OL</sub>	Low-level digital output	I <sub>OL</sub> = 50 μA			0.4	V
l <sub>OZ</sub>	Output current, high impedance				±10	μΑ
Clock 7	Fiming (CS low)					
f <sub>CLK</sub>	Clock frequency		0.1†	8	8	MHz
t <sub>d</sub>	Output delay time				25	ns
	Latency			9.5		Cycles

<sup>&</sup>lt;sup>†</sup> This parameter is not production tested.



#### PARAMETER MEASUREMENT INFORMATION

#### sample timing

The core is based on a pipeline architecture with a latency of 9.5 samples. The conversion results appear on the digital output 9.5 clock cycles after the input signal was sampled.

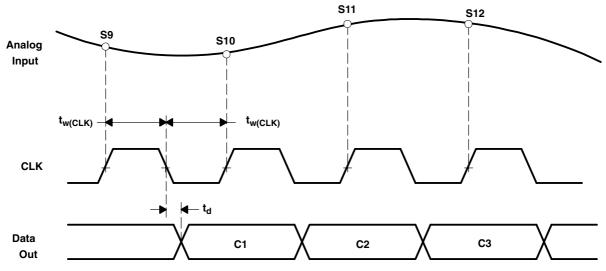


Figure 1. Sample Timing

The parallel interface of the ADC features 3-state buffers, making it possible to directly connect it to a data bus. The output buffers are enabled by driving the OE input low.

Besides the sample results, it is also possible to read back the values of the control register, the PGA register, and the offset register. Which register is read is determined by the address inputs A[1,0]. The ADC results are available at address 0.

The timing of the control signals is described in the following sections.

#### PARAMETER MEASUREMENT INFORMATION

### read timing (15-pF load)

	PARAMETER	MIN	TYP	MAX	UNIT
t <sub>su(OE-ACS)</sub>	Address and chip select setup time	4			ns
t <sub>en</sub>	Output enable			15	ns
t <sub>dis</sub>	Output disable		10		ns
t <sub>h(A)</sub>	Address hold time	1			ns
t <sub>h(CS)</sub>	Chip select hold time	0			ns

NOTE: All timing parameters refer to a 50% level.

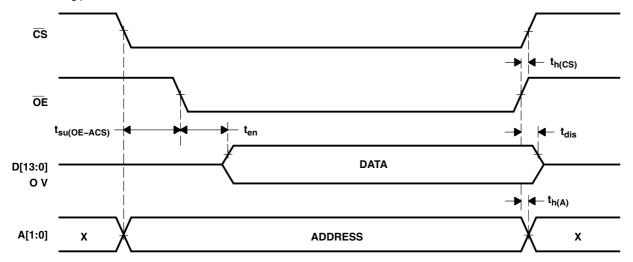


Figure 2. Read Timing



#### PARAMETER MEASUREMENT INFORMATION

### write timing (15-pF load)

	PARAMETER	MIN	TYP	MAX	UNIT
t <sub>su(WE-CS)</sub>	Chip select setup time	4			ns
t <sub>su(DA)</sub>	Data and address setup time	29			ns
t <sub>h(DA)</sub>	Data and address hold time	0			ns
t <sub>h(CS)</sub>	Chip select hold time	0			ns
t <sub>wH(WE)</sub>	Write pulse duration high	15			ns

NOTE: All timing parameters refer to a 50% level.

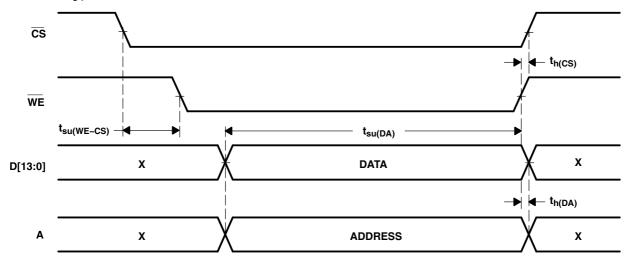
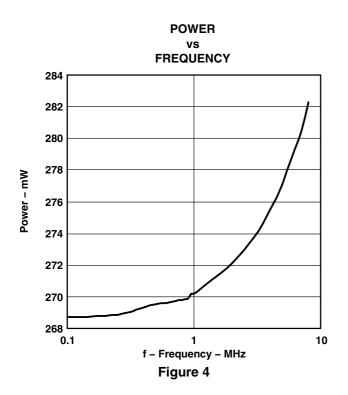
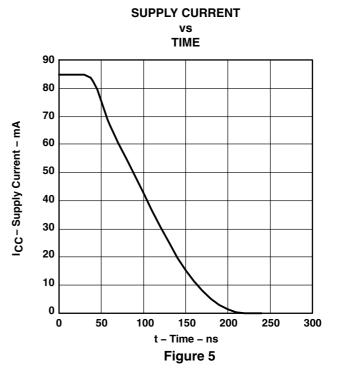


Figure 3. Write Timing

## **TYPICAL CHARACTERISTICS**





#### **TYPICAL CHARACTERISTICS**

#### **FAST FOURIER TRANSFORM**

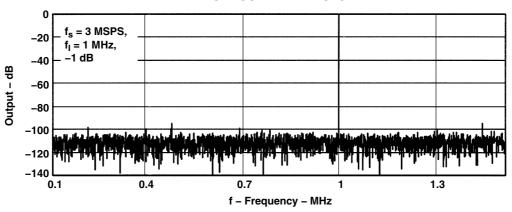


Figure 6

#### **FAST FOURIER TRANSFORM**

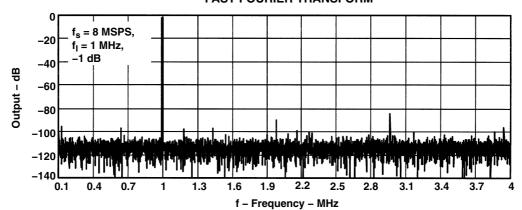


Figure 7

#### **TYPICAL CHARACTERISTICS**

#### **INTEGRAL NONLINEARITY** 2 INL - Integral Nonlinearity - LSB $f_s = 3 MSPS$ 1.5 0.5 -0.5 -1 -1.5 -2 2048 4096 8192 0 6144 10240 12288 14336 16384 Samples

Figure 8

#### INTEGRAL NONLINEARITY

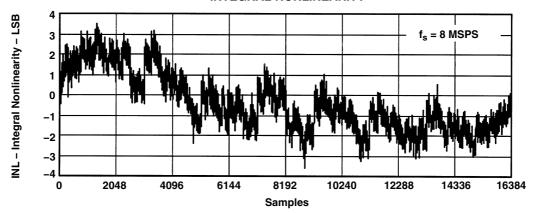


Figure 9

#### TYPICAL CHARACTERISTICS

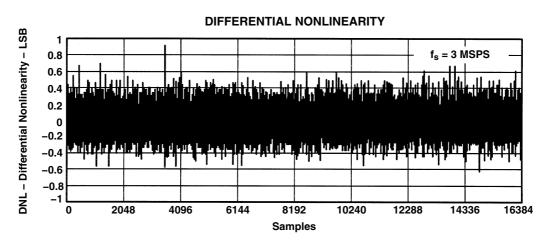


Figure 10

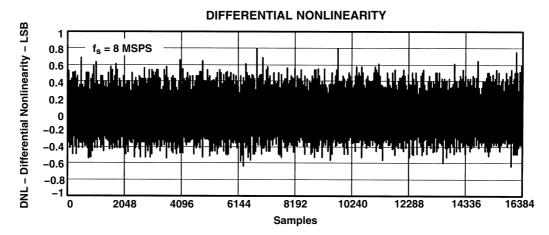
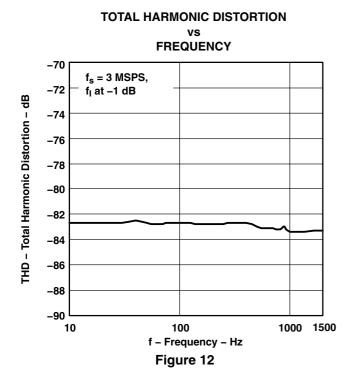
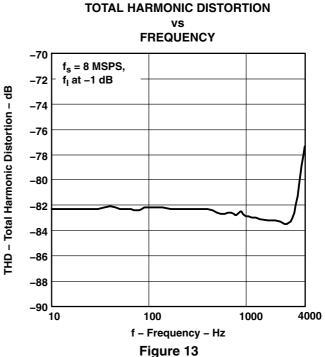
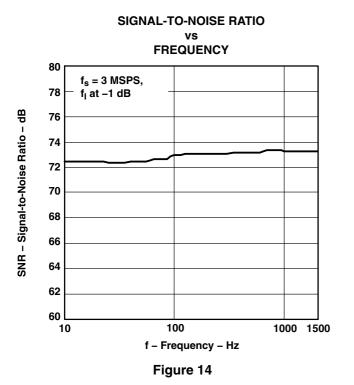


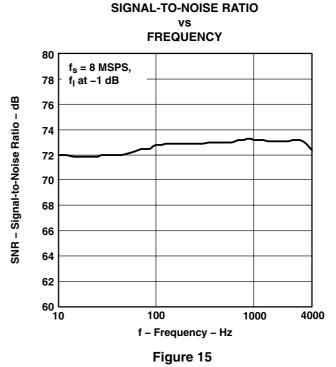
Figure 11

#### TYPICAL CHARACTERISTICS









#### PRINCIPLES OF OPERATION

#### registers

The device contains several registers. The A register is selected by the values of bits A1 and A0:

A1	A0	Register
0	0	Conversion result
0	1	PGA
1	0	Offset
1	1	Control

Tables 1 and 2 describe how to read the conversion results and how to configure the data converter. The default values (where applicable) show the state after a power-on reset.

Table 1. Conversion Result Register, Address 0, Read

BIT	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Function	MSB													LSB

The output can be configured for two's complement or straight binary format (see D11/control register).

The output code is given by:

2s complement: Straight binary:

-8192 at  $\Delta IN = -\Delta REF$  0 at  $\Delta IN = -\Delta REF$ 

0 at  $\Delta IN = 0$  8192 at  $\Delta IN = 0$ 

8191  $\triangle IN = -\triangle REF - 1 LSB$  16383 at  $\triangle IN = -\triangle REF - 1 LSB$ 

 $1 LSB = \frac{2\Delta REF}{16384}$ 

Table 2. PGA Gain Register, Address 1, Read/Write

BIT	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Function	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	G2	G1	G0
Default	0	0	0	0	0	0	0	0	0	0	0	0	0	0

The PGA gain is determined by writing to G2-0.

Gain (dB) =  $1dB \times G2-0$ . max = 7dB. The range of G2-0 is 0 to 7.

Table 3. Offset Register, Address 2, Read/Write

BIT	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Function	Х	Х	Х	Х	Х	Х	MSB							LSB
Default	0	0	0	0	0	0	0	0	0	0	0	0	0	0

The offset correction range is from -128 to 127 LSB. This value is added to the conversion results from the ADC.



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#### PRINCIPLES OF OPERATION

#### Table 4. Control Register, Address 3, Read

BIT	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Function	PWD	REF	FOR	TM2	TM1	TMO	OFF	RES						

#### Table 5. Control Register, Address 3, Write

BIT	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
Function	PWD	REF	FOR	TM2	TM1	TMO	OFF	RES						
Default	0	0	0	0	0	0	0	0	0	0	0	0	0	0

PWD: Power down 0 = normal operation 1 = power down

REF: Reference select 0 = internal reference 1 = external referenceFOR: Output format 0 = straight binary 1 = 2s complement

TM2-0: Test mode 000 = normal operation

001 = both inputs = REF-

010 = IN+ at  $V_{ref}/2$ , IN- at REF-011 = IN+ at REF+, IN- at REF-

100 = normal operation101 = both inputs = REF+

110 = IN+ at REF-, IN- at  $V_{ref}/2$ 111 = IN+ at REF-, IN- at REF+

OF: Offset correction 0 = enable 1 = disable

RES Reserved Must be set to 0.

#### APPLICATION INFORMATION

#### driving the analog input

The ADC has a fully differential input. A differential input is advantageous with respect to SNR, SFDR, and THD performance because the signal peak-to-peak level is 50% of a comparable single-ended input.

There are three basic input configurations:

- Fully differential
- Transformer coupled single-ended to differential
- Single-ended

#### fully differential configuration

In this configuration, the ADC converts the difference ( $\Delta$ IN) of the two input signals on IN+ and IN-.

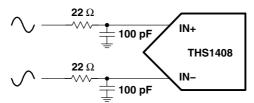


Figure 16. Differential Input

The resistors and capacitors on the inputs decouple the driving source output from the ADC input and also serve as first order low pass filters to attenuate out of band noise.

The input range on both inputs is 0 V to AV<sub>DD</sub>. The full-scale value is determined by the voltage reference. The positive full-scale output is reached, if  $\Delta$ IN equals  $\Delta$ REF, the negative full-scale output is reached, if  $\Delta$ IN equals  $-\Delta$ REF.

∆IN [V]	OUTPUT			
–∆REF	<ul><li>full scale</li></ul>			
0	0			
ΔREF	+ full scale			

#### APPLICATION INFORMATION

#### transformer coupled single-ended to differential configuration

If the application requires the best SNR, SFDR, and THD performance, the input should be transformer coupled.

The signal amplitude on both inputs of the ADC is one half as high as in a single-ended configuration thus increasing the ADC ac performance.

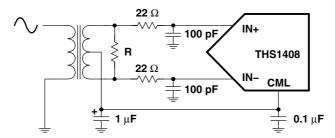


Figure 17. Transformer Coupled

The following table shows the input voltages for negative full-scale output, zero output, and positive full-scale output:

IN [V <sub>PEAK</sub> ]	OUTPUT [PEAK]				
-∆REF	<ul> <li>full scale<sup>†</sup></li> </ul>				
0	0				
ΔREF	+ full scale <sup>†</sup>				

† n = 1 (winding ratio)

The resistor R of the transformer coupled input configuration must be set to match the signal source impedance R =  $n^2$  Rs, where Rs is the source impedance and n is the transformer winding ratio.



#### **APPLICATION INFORMATION**

#### single-ended configuration

In this configuration, the input signal is level shifted by  $\Delta REF/2$ .

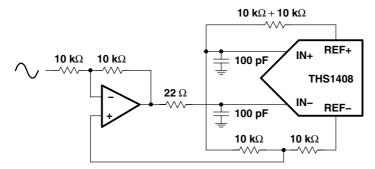


Figure 18. Single-Ended With Level Shift

The following table shows the input voltages for negative full-scale output, zero output, and positive full-scale output:

∆IN+ [V]	OUTPUT				
–∆REF	- full scale				
0	0				
ΔREF	+ full scale				

Note that the resistors of the op-amp and the op-amp all introduce gain and offset errors. Those errors can be trimmed by varying the values of the resistors.

Because of the added offset, the op-amp does not necessarily operate in the best region of its transfer curve (best linearity around zero) and, therefore, may introduce unacceptable distortion. For ac signals, an alternative is described in the following section.

#### **APPLICATION INFORMATION**

#### **AC-coupled single-ended configuration**

If the application does not require the signal bandwidth to include dc, the level shift shown in Figure 4 is not necessary.

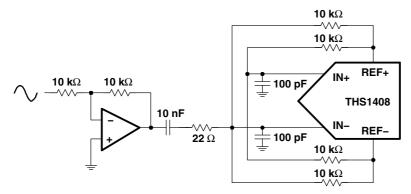


Figure 19. Single-Ended With Level Shift

Because the signal swing on the op-amp is centered around ground, it is more likely that the signal stays within the linear region of the op-amp transfer function, thus increasing the overall ac performance.

IN [V <sub>PEAK</sub> ]	OUTPUT [PEAK]				
–∆REF	– full scale				
0	0				
ΔREF	+ full scale				

Compared to the transformer-coupled configuration, the swing on IN- is twice as big, which can decrease the ac performance (SNR, SFD, and THD).



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#### APPLICATION INFORMATION

#### internal/external reference operation

The THS1408 ADC can either be operated using the built-in band gap reference or using an external precision reference in case very high dc accuracy is needed.

The REF+ and REF+ outputs are given by:

REF + = VBG
$$\left(1 + \frac{2}{3}\right)$$
 and REF- = VBG $\left(1 - \frac{2}{3}\right)$ 

If the built-in reference is used, VBG equals 1.5 V, which results in REF+ = 2.5 V, REF- = 0.5 V and  $\Delta$ REF = 2 V.

The internal reference can be disabled by writing 1 to D12 (REF) in the control register (address 3). The band gap reference is then disconnected and can be substituted by a voltage on the VBG pin.

#### programmable gain amplifier

The on-chip programmable gain amplifier (PGA) has eight gain settings. The gain can be changed by writing to the PGA gain register (address 1). The range is 0 to 7 dB in steps of one dB.

#### out of range indication

The OV output of the ADC indicates an out of range condition. Every time the difference on the analog inputs exceeds the differential reference, this signal is asserted. This signal is updated the same way as the digital data outputs and therefore subject to the same pipeline delay.

#### offset compensation

With the offset register it is possible to automatically compensate system offset errors, including errors caused by additional signal conditioning circuitry. If the offset compensation is enabled (D7 (OFF) in the control register), the value in the offset register (address 2) is automatically subtracted from the output of the ADC.

In order to set the correct value of the offset compensation register, the ADC result when the input signal is 0 must be read by the host processor and written to the offset register (address 2).

#### test modes

The ADC core operation can be tested by selecting one of the available test modes (see control register description). The test modes apply various voltages to the differential input depending on the setting in the control register.

#### digital I/O

The digital inputs and outputs of the THS1408 ADC are 3-V CMOS compatible. In order to avoid current feed back errors, the capacitive load on the digital outputs should be as low as possible (50 pF max). Series resistors (100  $\Omega$ ) on the digital outputs can improve the performance by limiting the current during output transitions.

The parallel interface of the THS1408 ADC features 3-state buffers, making it possible to directly connect it to a data bus. The output buffers are enabled by driving the  $\overline{OE}$  input low.

Refer to the read and write timing diagrams in the parameter measurement information section for information on read and write access.



#### PACKAGE OPTION ADDENDUM

www.ti.com 8-Feb-2010

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins P	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
THS1408MPHPEP	ACTIVE	HTQFP	PHP	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
V62/03608-03XE	ACTIVE	HTQFP	PHP	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND**: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF THS1408-EP:

Catalog: THS1408Military: THS1408M

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

# PHP (S-PQFP-G48)

# PowerPAD™ PLASTIC QUAD FLATPACK



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <a href="https://www.ti.com">www.ti.com</a>.
- E. Falls within JEDEC MS-026

PowerPAD is a trademark of Texas Instruments.



PHP (S-PQFP-G48)

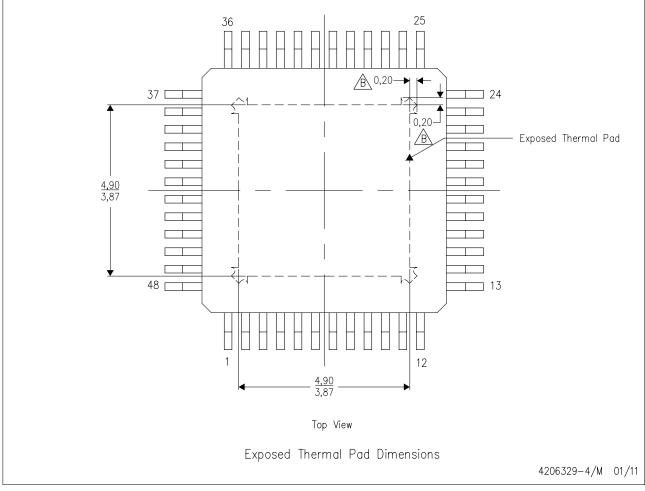
PowerPAD™ PLASTIC QUAD FLATPACK

#### THERMAL INFORMATION

This PowerPAD  $^{\text{M}}$  package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: A. All linear dimensions are in millimeters

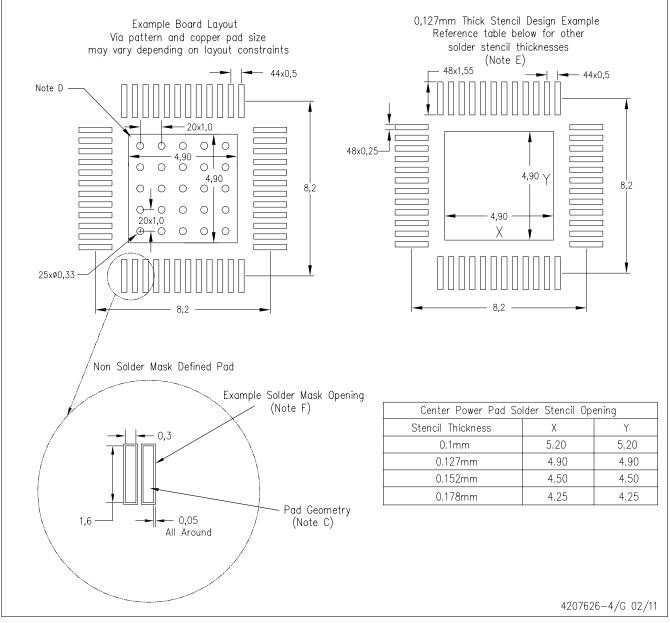
B Tie strap features may not be present.

PowerPAD is a trademark of Texas Instruments



# PHP (S-PQFP-G48)

# PowerPAD™ PLASTIC QUAD FLATPACK



#### NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting options for vias placed in the thermal pad.

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